

isc N-Channel MOSFET Transistor IPD060N03L, IIPD060N03L

• FEATURES

- Static drain-source on-resistance: $R_{DS(on)} \leq 6\text{m}\Omega$
- Enhancement mode:
- 100% avalanche tested
- Minimum Lot-to-Lot variations for robust device performance and reliable operation

• DESCRIPTION

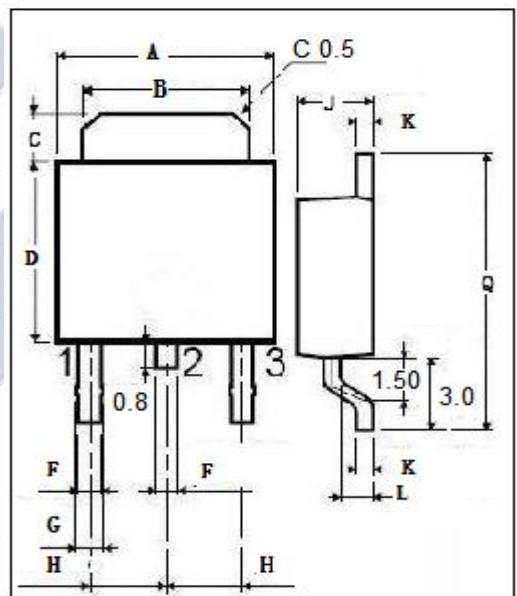
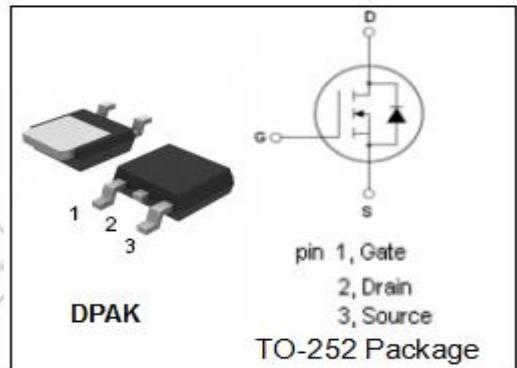
- Fast switching

• ABSOLUTE MAXIMUM RATINGS($T_a=25^\circ\text{C}$)

SYMBOL	PARAMETER	VALUE	UNIT
V_{DSS}	Drain-Source Voltage	30	V
V_{GS}	Gate-Source Voltage	± 20	V
I_D	Drain Current-Continuous	50	A
I_{DM}	Drain Current-Single Pulsed	350	A
P_D	Total Dissipation @ $T_c=25^\circ\text{C}$	56	W
T_j	Max. Operating Junction Temperature	175	$^\circ\text{C}$
T_{stg}	Storage Temperature	-55~175	$^\circ\text{C}$

• THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	MAX	UNIT
$R_{th(j-c)}$	Channel-to-case thermal resistance	2.7	$^\circ\text{C}/\text{W}$
$R_{th(j-a)}$	Channel-to-ambient thermal resistance	75	$^\circ\text{C}/\text{W}$



DIM	mm	
	MIN	MAX
A	6.40	6.60
B	5.20	5.40
C	1.15	1.35
D	5.70	6.10
F	0.65	
G	0.75	
H	2.10	2.50
J	2.10	2.40
K	0.40	0.60
L	0.90	1.10
Q	9.90	10.1

isc N-Channel MOSFET Transistor IPD060N03L, IIPD060N03L**ELECTRICAL CHARACTERISTICS** $T_c=25^\circ\text{C}$ unless otherwise specified

SYMBOL	PARAMETER	CONDITIONS	MIN	TYP	MAX	UNIT
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}; I_D=1\text{mA}$	30			V
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}; I_D=250 \mu\text{A}$	1		2.2	V
$R_{DS(\text{on})}$	Drain-Source On-Resistance	$V_{GS}=10\text{V}; I_D=30\text{A}$			6	$\text{m}\Omega$
I_{GSS}	Gate-Source Leakage Current	$V_{GS}= 20\text{V}; V_{DS}= 0\text{V}$			0.1	μA
I_{DSS}	Drain-Source Leakage Current	$V_{DS}=30\text{V}; V_{GS}= 0\text{V}$			1	μA
V_{SD}	Diode forward voltage	$I_F=30\text{A}, V_{GS} = 0\text{V}$			1.1	V